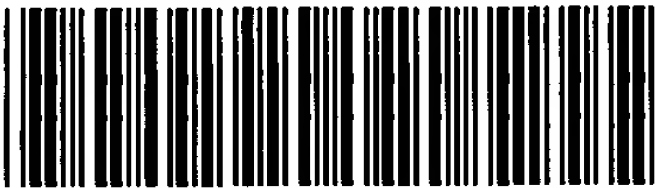


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/852,578	UCHIO ET AL.	
	Examiner	Art Unit	
	Paul Nguyen-Ba	2176	

SEARCHED			
Class	Subclass	Date	Examiner
715	503 509 530 500	1/19/2007	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST DATABASE SEARCH (see attached search notes)		
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